

**Search Notes**

Application/Control No.

10/716,250

Examiner

Dao H. Nguyen

Applicant(s)/Patent under  
Reexamination

DENG ET AL.

Art Unit

2818

**SEARCHED**

Class	Subclass	Date	Examiner
257	758,767,e 21.581	7/22/2007	DN
438	623,633	7/22/2007	DN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
(See search history print out).		7/22/2007	DN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPAT; USPG-PUB; EPO; JPO; IBM-TDB; USOCR)  (See search history print out).	7/22/2007	DN
257/751,758,759,762,775,e21.259,e2 1.273,e23.167 (text search)	7/22/2007	DN
438/207,622,623,633,638 (text search)	7/22/2007	DN